

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : TBD Confirmation No.: TBD
Applicant : Randolph W. Kahn et al.
Filed : 12/4/2003
TC/A.U. : TBD
Examiner : TBD

Docket No. : TI-24186.1
Customer No. : 23494

Title : IN-SITU RANDOMIZATION AND RECORDING OF WAFER
PROCESSING ORDER AT PROCESS TOOLS

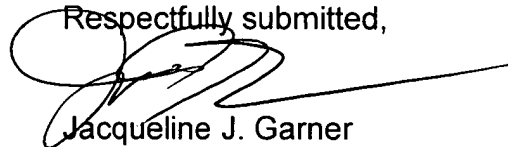
INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner for Patents
Washington, DC 20231

Dear Sir:

Please make the references listed on the enclosed PTO-1449 of record under 37 C.F.R. 1.56, 1.97, and 1.98 in the patent application identified above. Copies of the listed references are not enclosed as per 37 C.F.R. 1.98(d). The listed references were previously submitted to, or cited by, the Patent Office in an earlier application U.S. Serial No. 09/997,930, filed 11/30/2001 which is relied on for an earlier effective filing date under 35 U.S.C. 120.

Respectfully submitted,



Jacqueline J. Garner
Attorney for Applicants
Reg. No. 36,144

Texas Instruments Incorporated
P. O. Box 655474, MS 3999
Dallas, Texas 75265
(214) 532-9348 or (972) 917-5643
(972)917-4418 Fax

Please type a plus sign (+) inside this box ☐

PTO/SB/08A (08-00)

Approved for use through 10/31/2002. OMB 0651-0031
Patent and Trademark Office: U.S. DEPARTMENT OF COMMERCE

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it displays a valid OMB control number.

				Complete If Known	
				Application Number	TBD
				Filing Date	12/4/2003
				First Named Inventor	Randolph W. Kahn
				Group Art Unit	TBD
				Examiner Name	TBD
Sheet	1	of	1	Attorney Docket No.	TI-24186.1

U.S. PATENT DOCUMENTS						
Exam. Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Doc.	Date of Pub. of Cited Doc. (mm-yyyy)	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
	AA	5,183,370		Cruz	02-1993	
	AB	5,761,065		Kittler et al.	06-1998	
	AC	6,180,424		Tigelaar et al.	01-2001	
	AD	6,213,708		Allen	04-2001	
	AE	6,336,086		Perez et al.	01-2002	
	AF	6,599,763		Reyes et al.	07-2003	
	AG					
	AH					

FOREIGN PATENT DOCUMENTS								
Exam. Initials*	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Doc.	Date of Pub. of Cited Doc. (mm-dd-yyyy)	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Office ³	Number ⁴	Kind Code ² (if known)				
	BA							
	BB							
	BC							
	BD							
	BE							
	BF							
	BG							
	BH							

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Exam. Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	CA		
	CB		
	CC		
	CD		
	CE		
	CF		
	CG		
	CH		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

US and Foreign Patent Documents: ¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

Other Prior Art/Non-Patent Literature Documents: ¹Unique citation designation number. ²Applicant is to place a check mark here if English Translation is attached.

Burden Hour Statement: This form is estimated to take 2.0 hours to complete. Time will vary depending upon the needs of the individual case. Any comments on the amount of time you are required to complete this form should be sent to the Chief Information Officer, Patent and Trademark Office, Washington, DC 20231. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Assistant Commissioner for Patents, Washington, DC 20231